

OPTICAL PROPERTIES OF MOLECULAR BEAM EPITAXY GROWN (Mo,Mn)Se₂, MoSe₂, AND MnSe Julia Kucharek, Wojciech Pacuski

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Doping non-magnetic semiconductors with magnetic ions such as Mn leads to formation of diluted magnetic semiconductors (DMS) e.g. (Cd,Mn)Te or (Ga,Mn)As. DMS exhibit enhanced magneto-optical properties and fascinating magnetic phenomena as for example carrier mediated ferromagnetism. Aim of this work is to answer if above concept can be applied to layered graphene-like two dimensional (2D) materials, such as transition metal dichalcogenides (TMD). To study impact of Mn ions on properties of TMD we have grown in the same conditions: undoped molybdenum diselenide (MoSe₂), molybdenum diselenide doped with manganese ((Mo,Mn)Se₂), and manganese selenide (MnSe) - as a reference. We used molecular beam epitaxy and two kinds of substrates: Si with polycrystalline SiO₂ buffer and Al₂O₃.

On Si/SiO₂ substrate we have grown a series of samples with various amount of deposited Mn, while amount of Mo and Se were kept constant (optimized for 1 monolayer of MoSe₂). Next, we investigated all samples using room temperature optical spectroscopy: Raman scattering and photoluminescence. We observe that characteristic Raman line of MoSe₂ at 241 cm⁻¹ only weakly evolved with increasing amount of Mn, but other spectral lines appear in the Raman spectrum of (Mo,Mn)Se₂. Also, we found that the addition of manganese has not significantly altered the result of photoluminescence. There are only very weak effects of photoluminescence quenching. It is in contrast to most of diluted magnetic semiconductors, where Mn ions are known to induce effect of total photoluminescence quenching. What is new, for high amount of Mn, new photoluminescence bands appear. We have found that Si substrate with 90 nm thick SiO₂ buffer is very convenient for optical study of (Mo,Mn)Se₂, because of constructive optical interferences. On the other hand, such kind of polycrystalline buffer gives no hope for growth of large monocrystalline layers. This is why we decided to start work on Al₂O₃ substrates also.

Samples grown on c-plane Al₂O₃ were analyzed in situ using Reflection High Energy Electron Diffraction (RHEED). This technique confirmed that in particular conditions growth of well oriented crystals is possible. Further optical microscopy analysis showed that crystals have typical sizes of 1 micrometer, so structure is not a monocrystal. Thanks to transparency of Al₂O₃, transmittance measurements were performed on obtained layers.